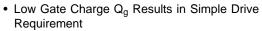


RJK5032DPP-E0-VB Datasheet

N-Channel 650V (D-S) Power MOSFET

PRODUCT SUMMA	RY	
V _{DS} (V)	650)
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 10 V	2.5
Q _g (Max.) (nC)	48	
Q _{gs} (nC)	12	
Q _{gd} (nC)	19	
Configuration	Sing	le

FEATURES



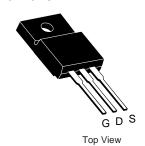


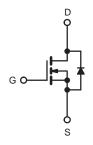
• Improved Gate, Avalanche and Dynamic dV/dt Ruggedness



- Fully Characterized Capacitance and Avalanche Voltage and Current
- Compliant to RoHS directive 2002/95/EC







N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS To	_C = 25 °C, u	nless otherw	ise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	650	V	
Gate-Source Voltage			V_{GS}	± 30	V	
Continuous Drain Currente	V _{GS} at 10 V	T _C = 25 °C	,	4		
Continuous Drain Current	V _{GS} at 10 V	T _C = 100 °C	I _D	3.8	Α	
Pulsed Drain Current ^a			I _{DM}	18		
Linear Derating Factor				0.48	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	325	mJ	
Repetitive Avalanche Currenta			I _{AR}	4	Α	
Repetitive Avalanche Energy ^a			E _{AR}	6	mJ	
Maximum Power Dissipation	T _C =	25 °C	P_{D}	30	W	
Peak Diode Recovery dV/dt ^c			dV/dt	2.8	V/ns	
Operating Junction and Storage Temperature Range			T_J,T_stg	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature) ^d	for	10 s		300		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
woulding rorque	que 0-52 01 IVIS SCIEW 1	1.1	N⋅m			

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Starting T_J = 25 °C, L = 24 mH, R_G = 25 Ω , I_{AS} = 3.2 A (see fig. 12).
- c. $I_{SD} \le 3.2$ A, $dI/dt \le 90$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.
- d. 1.6 mm from case.
- e. Drain current limited by maximum junction temperature.



THERMAL RESISTANCE RAT	TINGS			
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	65	°C/W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	2.1	C/VV

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V_{DS}	V _{GS} :	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I _D = 1 mA ^d	-	670	-	mV/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	,	$V_{GS} = \pm 30 \text{ V}$	ı	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		= 650 V, V _{GS} = 0 V V, V _{GS} = 0 V, T _J = 125 °C	-	-	25 250	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 3.1 A ^b	-	2.5	-	Ω
Forward Transconductance	9 _{fs}	V _{DS}	= 50 V, I _D = 3.1 A	3.9	-	-	S
Dynamic							
Input Capacitance	C _{iss}		$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$		1080	-	
Output Capacitance	C _{oss}	1			177	-	
Reverse Transfer Capacitance	C _{rss}	f = 1	.0 MHz, see fig. 5	-	7.0	-	pF
Output Capacitance	C _{oss}		V _{DS} = 1.0 V, f = 1.0 MHz	-	1912	-	
Output Capacitance		$V_{GS} = 0 V$	$V_{DS} = 520 \text{ V}, f = 1.0 \text{ MHz}$	ı	48	-	
Effective Output Capacitance	Coss eff.		$V_{DS} = 0 \text{ V to } 520 \text{ V}^{c}$	-	84	-	
Total Gate Charge	Q_g			-	-	48	
Gate-Source Charge	Q_{gs}	V _{GS} = 10 V	$I_D = 3.2 \text{ A}, V_{DS} = 400 \text{ V}$ see fig. 6 and 13^b	=	-	12	nC
Gate-Drain Charge	Q _{gd}			-	-	19	
Turn-On Delay Time	t _{d(on)}			-	14	-	
Rise Time	t _r		$V_{DD} = 325 \text{ V}, I_D = 3.2 \text{ A}$ $R_G = 9.1 \Omega, R_D = 62 \Omega,$ see fig. 10 ^b		20	-	- ns
Turn-Off Delay Time	t _{d(off)}	$R_{G} =$			34	-	
Fall Time	t _f	1		-	18	-	
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	showing the	/ : T/		-	4	A
Pulsed Diode Forward Current ^a	I _{SM}	p - n junction diode		ı	-	21	
Body Diode Voltage	V_{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = 3.2 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	-	1.5	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 3.2 A, dI/dt = 100 A/µs ^b		ı	493	739	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	2.1	3.2	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	ırn-on time is negligible (turn-	on is don	ninated by	y L _S and	L _D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 µs; duty cycle \leq 2 %.
- c. C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS} .

d. t = 60 s, f = 60 Hz.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

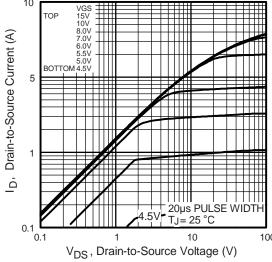


Fig. 1 - Typical Output Characteristics

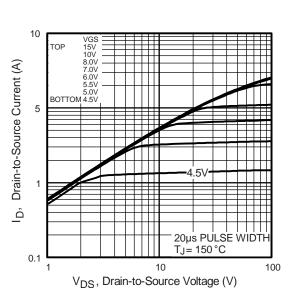


Fig. 2 - Typical Output Characteristics

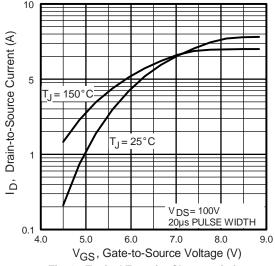


Fig. 3 - Typical Transfer Characteristics

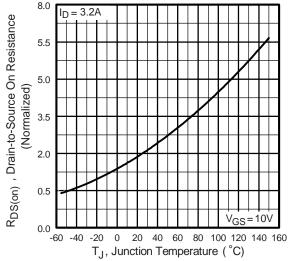


Fig. 4 - Normalized On-Resistance vs. Temperature



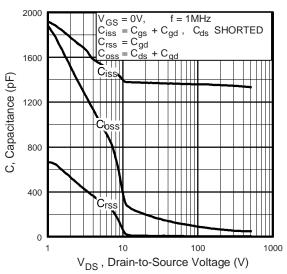


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

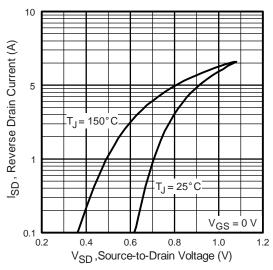


Fig. 7 - Typical Source-Drain Diode Forward Voltage

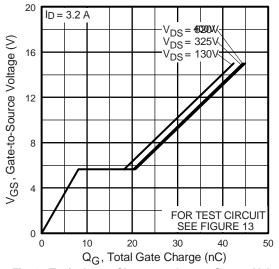


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

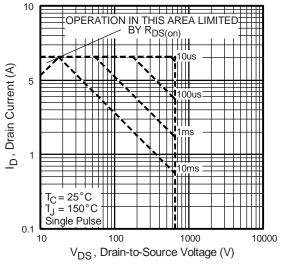


Fig. 8 - Maximum Safe Operating Area



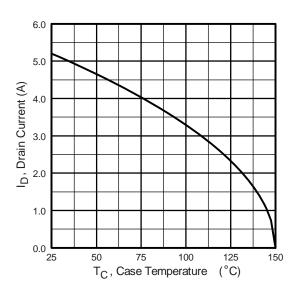


Fig. 9 - Maximum Drain Current vs. Case Temperature

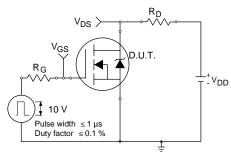


Fig. 10a - Switching Time Test Circuit

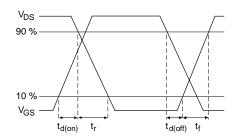


Fig. 10b - Switching Time Waveforms

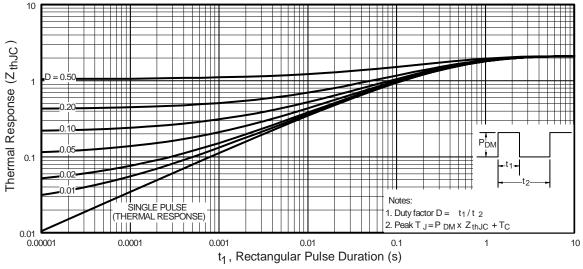


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

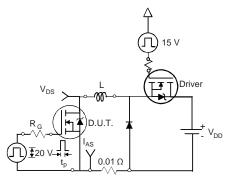


Fig. 12a - Unclamped Inductive Test Circuit

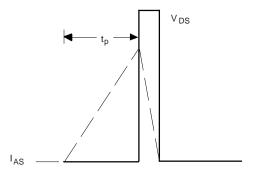


Fig. 12b - Unclamped Inductive Waveforms



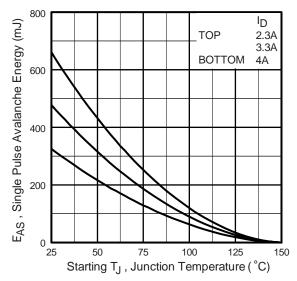


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

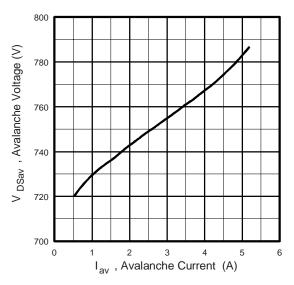


Fig. 12d - Typical Drain-to Source Voltage vs. Avalanche Current

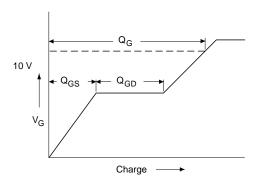


Fig. 13a - Basic Gate Charge Waveform

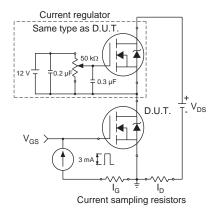
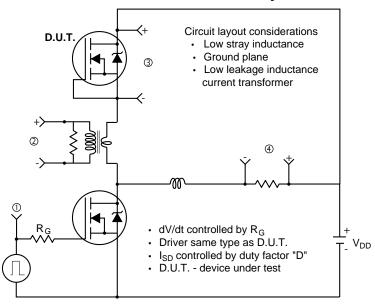


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



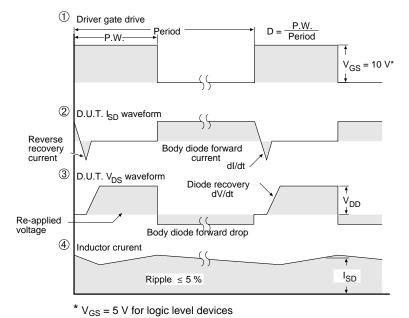
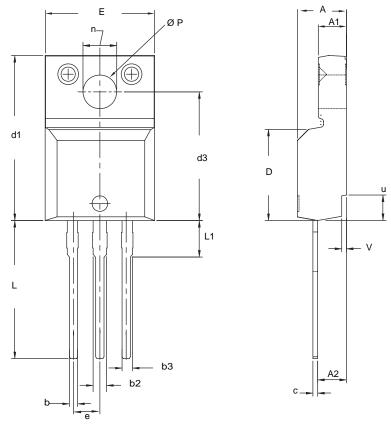


Fig. 14 - For N-Channel



TO-220 FULLPAK (HIGH VOLTAGE)



DIM.	MILLIN	METERS	INCHES		
	MIN.	MAX.	MIN.	MAX.	
Α	4.570	4.830	0.180	0.190	
A1	2.570	2.830	0.101	0.111	
A2	2.510	2.850	0.099	0.112	
b	0.622	0.890	0.024	0.035	
b2	1.229	1.400	0.048	0.055	
b3	1.229	1.400	0.048	0.055	
С	0.440	0.629	0.017	0.025	
D	8.650	9.800	0.341	0.386	
d1	15.88	16.120	0.622	0.635	
d3	12.300	12.920	0.484	0.509	
E	10.360	10.630	0.408	0.419	
е	2.54	BSC	0.100	BSC	
L	13.200	13.730	0.520	0.541	
L1	3.100	3.500	0.122	0.138	
n	6.050	6.150	0.238	0.242	
ØΡ	3.050	3.450	0.120	0.136	
u	2.400	2.500	0.094	0.098	
V	0.400	0.500	0.016	0.020	

Notes

- To be used only for process drawing.
 These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads.
 All critical dimensions should C meet C_{pk} > 1.33.
 All dimensions include burrs and plating thickness.

- 5. No chipping or package damage.



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